

<b>Notice of References Cited</b>	Application/Control No. 10/562,438		Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner Ben Lewis		Art Unit 1745	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,705,292	01-1998	Yukita et al.	429/137
*	B	US-2002/0055036 A1	05-2002	Shinohara et al.	429/62
*	C	US-6,365,300 B1	04-2002	Ota et al.	429/304
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2004-010701	06-2002	Japan	Akashi Kauzo	429/246
	O	09-147916	11-1995	Japan	Inoue et al.	429/246
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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